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AMENDMENTS TO THE CLAIMS

Claims 1-20 (Cancelled)

21. (Previously presented) A method of testing for faults in an electrical circuit, the circuit having a load, the method comprising the steps of:

providing a fault monitor, having:

a power supply connected in series with a resistor;

a connection for connecting to the circuit with the load in parallel with the resistor;

a voltage sensor connected in series with the resistor; and switching means for opening and closing the connection between the power supply and the resistor and load;

providing a test switching means connected in series with the resistor and in parallel with the current sensor, in sequence after the first transistor; closing the test switching means;

determining whether voltage is sensed by the voltage sensor, thereby:

determining whether current is flowing through the load;

connecting the fault monitor to the circuit with the load in parallel with the resistor;

passing a current through the circuit and fault monitor; and
detecting the resulting voltage at the voltage sensor, thereby determining
whether the total resistance provided by the load indicates a failure within the load and

also determining a number of elements having faults within the load based on the difference between the resulting voltage and an expected voltage.

- 22. (Original) The method according to claim 21, wherein the steps of closing the test switching means and determining whether voltage is sensed by the voltage sensor are performed before passing a current through the circuit and fault monitor, and detecting the resulting current at the current sensor.
- 23. (Original) The method according to claim 21, wherein the steps of closing the test switching means and determining whether voltage is sensed by the voltage sensor are performed after passing a current through the circuit and fault monitor, and detecting the resulting voltage at the voltage sensor.

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